Search Notes		

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/706,948	PAN ET AL.	
	Examiner	Art Unit	_
	Anh D. Mai	2814	

	SEAR	CHED	
Class	Subclass	Date	Examiner
438	193; 197 199; 300 585	2/16/2006	A.M
257	241; 243 287	2/16/6	A.M
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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See attach His	es Search tory	2/17/6	A.M

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST; IEEE Xplore See attached Search History	2/16/2006	A.M